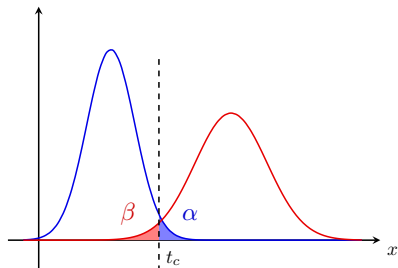


# Hypothesis testing

EE209 - Éléments de Statistiques pour les Data Sciences

# Telling apart two distributions based on an observation



Let's assume that  $X$  can follow two distributions:

- Under the *null hypothesis*  $H_0 : X \sim \mathcal{N}(\mu_0, \sigma_0^2)$
- Under the *alternate hypothesis*  $H_1 : X \sim \mathcal{N}(\mu_1, \sigma_1^2)$ ,

with  $\mu_0 < \mu_1$  and  $\sigma_0, \sigma_1$  not too large.

Can we try to decide based on an observation  $x$  of  $X$  which hypothesis is the correct one?

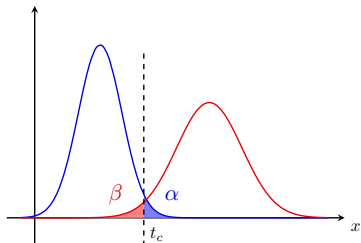
We can choose a *critical value*  $t_c$  on the value  $x$ , and

- if  $x \leq t_c$ , decide that  $H_0$  is correct
- if  $x > t_c$ , decide that  $H_1$  is correct

We can define

- $\alpha = \mathbb{P}_0(X > t_c)$  where  $\mathbb{P}_0$  is “the probability **if**  $H_0$  is true”
- $\beta = \mathbb{P}_1(X \leq t_c)$  where  $\mathbb{P}_1$  is “the probability **if**  $H_1$  is true”

## Types of errors



With the same setting as on previous slide, let's denote by  $\Delta$  our decision with

- $\Delta = 0$  if we decide that  $H_0$  is correct
- $\Delta = 1$  if we decide that  $H_1$  is correct

We have:

- $\{\Delta = 0\} = \{X \leq t_c\}$  and
- $\{\Delta = 1\} = \{X > t_c\}$

	$\Delta = 0$	$\Delta = 1$
$H_0$	😊	Type I-error ☹️
$H_1$	Type II-error ☹️	😊

$$\mathbb{P}_0(\Delta = 1) = \mathbb{P}_0(X > t_c) = \alpha$$

$$\mathbb{P}_1(\Delta = 0) = \mathbb{P}_0(X \leq t_c) = \beta$$

The probabilities of the configurations are

	$\Delta = 0$	$\Delta = 1$
$H_0$	$1 - \alpha$	$\alpha$
$H_1$	$\beta$	$1 - \beta$

# Telling apart two distributions based on a sample

Let's assume that  $X_1, \dots, X_n$  are i.i.d. but can follow two distributions:

- Hypothesis  $H_0 : X_i \stackrel{\text{iid}}{\sim} \mathcal{N}(\mu_0, \sigma_0^2)$
- Hypothesis  $H_1 : X_i \stackrel{\text{iid}}{\sim} \mathcal{N}(\mu_1, \sigma_1^2),$

Can we try to decide based on a sample  $x_1, \dots, x_n$  which hypothesis is the correct one?

We can for example compute  $\bar{x}$  and use the fact that

- Hypothesis  $H_0 : \bar{X} \sim \mathcal{N}(\mu_0, \frac{\sigma_0^2}{n})$
- Hypothesis  $H_1 : \bar{X} \sim \mathcal{N}(\mu_1, \frac{\sigma_1^2}{n}),$

Since the variance decrease with  $n$ , with a well chosen  $t_c$ , the probability of error should decrease with  $n$ .

## Testing an alternative with one hypothesis to privilege by default

When deciding between hypotheses, the situation is very often asymmetric: there is one hypothesis which should be privileged by default.

### **Ham vs spam.**

If a spam filter has to decide between two hypotheses

- This email is valid correspondence ("ham")
- This email is spam

it is much worse to classify ham as spam than the opposite.

By default we would rather consider that a mail is ham. This will be the null hypothesis,  $H_0$ .

### **Tumor vs not.**

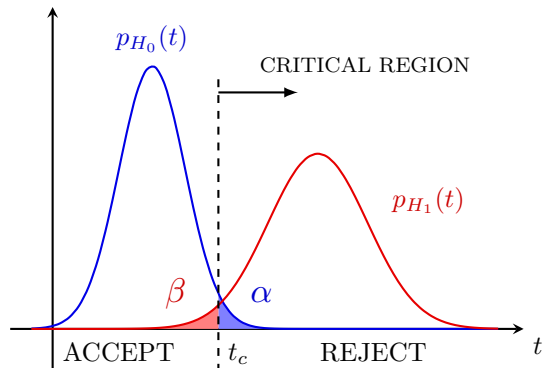
If the result of an analysis based on a radio or a CT-SCAN has to detect the presence of a tumor, it is much worse to fail to detect an existing tumor than to detect something which will turn out later not to be. So here the null hypothesis  $H_0$  will be "there is a tumor."

# The Neyman-Pearson hypothesis testing framework

We assume that

- the data follows a distribution  $p(\cdot; \theta)$  from a statistical model parameterized by  $\theta \in \Theta$ .
- Under the null hypothesis  $\theta \in H_0 \subset \Theta$ , and under the alternate hypothesis,  $\theta \in H_1 \subset \Theta$ .
- $H_0 \cap H_1 = \emptyset$ .
- We assume that there is a *statistic* of the data  $T = T(X_1, \dots, X_n)$  which tends to be small under  $H_0$  and larger under  $H_1$
- The null hypothesis  $H_0$  is privileged by default
- Our priority is to make sure that the Type-I error  $\alpha = \mathbb{P}_0(\Delta = 1)$  is low.
- We will thus choose the *critical value*  $t_c$  on  $T$  to guarantee that  $\alpha$  is low.

# The Neyman-Pearson testing framework: vocabulary



- $\alpha$  is the **significance level** (Type-I error)
- $1 - \alpha$  is the confidence level
- $\beta$  is the **Type-II error level**
- $1 - \beta$  is the power

- We will decide that  $H_1$  is correct (i.e. set  $\Delta = 1$ ) typically if  $T \in [t_c, +\infty)$  which is called the *critical region* of the test. This set can take other forms.
- if  $\Delta = 1$  we say that “we reject the null hypothesis” and that the result is “statistically significant.”

## One-sided Gaussian test

We assume that  $X_1, \dots, X_n \stackrel{\text{iid}}{\sim} \mathcal{N}(\mu, \sigma^2)$  where  $\sigma$  is known.

- We consider the simple alternative  $H_0 : \mu = \mu_0$  vs  $H_1 : \mu = \mu_1$  with  $\mu_1 > \mu_0$ .
- We consider the *test statistic*

$$T(X_1, \dots, X_n) = T := \frac{\bar{X} - \mu_0}{\sigma/\sqrt{n}}.$$

We have  $T \stackrel{H_0}{\sim} \mathcal{N}(0, 1)$ , so  $\mathbb{P}_0(T > z_{1-\alpha}) = \alpha$  and we can choose  $t_c = z_{1-\alpha}$  to control the type-I error.

We will reject the null hypothesis if  $T$  falls in the *critical region*  $[z_{1-\alpha}, +\infty)$ . In that case, we also say that  $\bar{X}$  is *significantly larger* than  $\mu_0$ .

We have  $T - \frac{\mu_1 - \mu_0}{\sigma/\sqrt{n}} \stackrel{H_1}{\sim} \mathcal{N}(0, 1)$ , so

$$\beta = \mathbb{P}_1(T \leq t_c) = \mathbb{P}_1\left(T - \frac{\mu_1 - \mu_0}{\sigma/\sqrt{n}} \leq t_c - \frac{\mu_1 - \mu_0}{\sigma/\sqrt{n}}\right) = \Phi\left(-\sqrt{n}\left(\frac{\mu_1 - \mu_0}{\sigma}\right) + t_c\right)$$



## Simple hypothesis vs composite hypothesis

A simple hypothesis is a hypothesis  $H_k = \{\theta_k\}$  which specifies a single value for  $\theta$ . A non-simple hypothesis is called a *composite* hypothesis.

### Simple alternative

$$H_0 : \theta = \theta_0 \quad \text{vs} \quad H_1 : \theta = \theta_1.$$

### Composite alternative

Assuming that  $\theta \in \mathbb{R}$ ,

$$H_0 : \theta = \theta_0 \quad \text{vs} \quad H_1 : \theta > \theta_0.$$

$$H_0 : \theta = \theta_0 \quad \text{vs} \quad H_1 : \theta < \theta_0.$$

$$H_0 : \theta = \theta_0 \quad \text{vs} \quad H_1 : \theta \neq \theta_0.$$

## Other alternatives leading to the one-sided Gaussian test

$$H_0 : \mu = \mu_0 \quad \text{vs} \quad H_1 : \mu > \mu_0$$

Given that  $t_c$  is only determined by the distribution under  $H_0$ , the *critical region* is again  $[z_{1-\alpha}, +\infty)$

$$H_0 : \mu = \mu_0 \quad \text{vs} \quad H_1 : \mu = \mu_1 \text{ with } \mu_1 < \mu_0.$$

In this case, we can reject if  $T$  is lower than an *critical value* such that  $\mathbb{P}_0(T < t_c) = \alpha$ , which entails  $t_c = z_\alpha$ . Of course, the *critical region* is now  $(-\infty, z_\alpha]$ .

$$H_0 : \mu = \mu_0 \quad \text{vs} \quad H_1 : \mu < \mu_0$$

Given that  $t_c$  is only determined by the distribution under  $H_0$ , this case is the same as the case just before for the determination of the *critical region*.

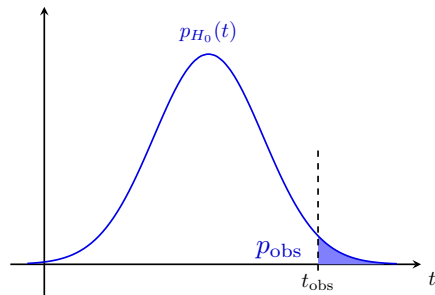
## p-value

One limitation of the test methodology that we have to choose a *significance level*  $\alpha$ . It could be useful to report a value such that one can easily assess whether the test would be rejected at other levels and which would directly measure the significance of the value  $t_{\text{obs}}$ .

### p-value definition

If  $t_{\text{obs}}$  is the observed value of the *test statistic*  $T$  then the associated p-value is

$$p_{\text{obs}} = \mathbb{P}_0(T \geq t_{\text{obs}}).$$



# Interpretations of the p-value

The p-value is

- the probability to observe a more extreme value of  $T$  than  $t_{\text{obs}}$  under  $H_0$ .
- the smallest significance level such that the null would be rejected for  $T = t_{\text{obs}}$ .
- the significance level of the test with  $t_c = t_{\text{obs}}$ .
- a measure of significance of the test statistic value  $t_{\text{obs}}$ .

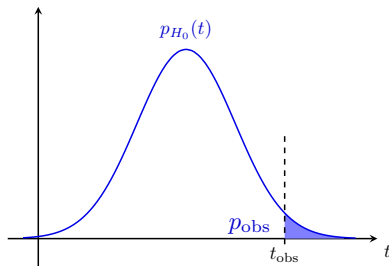
## Test decision in terms of the p-value

By definition  $H_0$  is rejected iff  $(t_{\text{obs}} > t_c) \Leftrightarrow (p_{\text{obs}} < \alpha)$ .

*Example:* p-value for a one-sided Gaussian test.

We have  $T \stackrel{H_0}{\sim} \mathcal{N}(0, 1)$ , so

$$p_{\text{obs}} = \mathbb{P}_0(T \geq t_{\text{obs}}) = 1 - \Phi(t_{\text{obs}}).$$



## Two-sided Gaussian test

We assume that  $X_1, \dots, X_n \stackrel{\text{iid}}{\sim} \mathcal{N}(\mu, \sigma^2)$  where  $\sigma$  is known.

- We consider the composite alternative  $H_0 : \mu = \mu_0$  vs  $H_1 : \mu \neq \mu_0$ .
- We consider the *test statistic*

$$|T(X_1, \dots, X_n)| = |T| := \left| \frac{\bar{X} - \mu_0}{\sigma/\sqrt{n}} \right|.$$

We have  $T \stackrel{H_0}{\sim} \mathcal{N}(0, 1)$ , so  $\mathbb{P}_0(|T| > z_{1-\alpha/2}) = 1 - \mathbb{P}_0(z_{\alpha/2} \leq T \leq z_{1-\alpha/2}) = \alpha$  and we can choose  $t_c = z_{1-\alpha/2}$  to control the type-I error.

In case of rejection of the null hypothesis, we say that  $\bar{X}$  is *significantly different* from  $\mu_0$ .

The p-value is  $p_{\text{obs}} = \mathbb{P}_0(|T| \geq |t_{\text{obs}}|) = 2(1 - \Phi(|t_{\text{obs}}|))$ .

## Relationship between Gaussian confidence intervals and Gaussian tests

### Two-sided test:

The null hypothesis is **not** rejected iff as  $|T| \leq t_c$  but

$$-t_c \leq \frac{\bar{X} - \mu_0}{\sigma/\sqrt{n}} \leq t_c \quad \Leftrightarrow \quad \bar{X} - t_c \frac{\sigma}{\sqrt{n}} \leq \mu_0 \leq \bar{X} + t_c \frac{\sigma}{\sqrt{n}}.$$

But  $t_c = z_{1-\alpha/2}$ , so the null hypothesis is rejected at the level of significance  $\alpha$  iff

$$\mu_0 \notin \left[ \bar{X} - z_{1-\alpha/2} \frac{\sigma}{\sqrt{n}}, \bar{X} + z_{1-\alpha/2} \frac{\sigma}{\sqrt{n}} \right].$$

In other words:

The hypothesis that  $\mu = \mu_0$  is rejected at a level of significance  $\alpha$   
if and only if

$\mu_0$  is not inside the (symmetric) Gaussian confidence interval of level  $1 - \alpha$ .

## Relationship between Gaussian confidence intervals and Gaussian tests

### One-sided test:

The null hypothesis is **not** rejected iff as  $T \leq t_c$  but

$$\frac{\bar{X} - \mu_0}{\sigma/\sqrt{n}} \leq t_c \quad \Leftrightarrow \quad \bar{X} \leq \mu_0 + t_c \frac{\sigma}{\sqrt{n}} \quad \Leftrightarrow \quad \bar{X} - t_c \frac{\sigma}{\sqrt{n}} \leq \mu_0.$$

But  $t_c = z_{1-\alpha}$ , so the null hypothesis is rejected at the level of significance  $\alpha$  iff

$$\mu_0 \notin \left[ \bar{X} - z_{1-\alpha} \frac{\sigma}{\sqrt{n}}, +\infty \right).$$

In other words:

The hypothesis that  $\mu = \mu_0$  is rejected at a level of significance  $\alpha$   
if and only if

$\mu_0$  is not inside the semi-infinite upper Gaussian confidence interval of level  $1 - \alpha$ .

## One-sided Student test

We assume that  $X_1, \dots, X_n \stackrel{\text{iid}}{\sim} \mathcal{N}(\mu, \sigma^2)$  where  $\sigma$  is **unknown**.

- We consider the simple alternative  $H_0 : \mu = \mu_0$  vs  $H_1 : \mu = \mu_1$  with  $\mu_1 > \mu_0$ .
- We consider the *test statistic*

$$T(X_1, \dots, X_n) = T := \frac{\bar{X} - \mu_0}{S/\sqrt{n}}.$$

We have  $T \stackrel{H_0}{\sim} \text{St}_{n-1}$ , so  $\mathbb{P}_0(T > t_{1-\alpha}^{(n-1)}) = \alpha$  and we can choose  $t_c = t_{1-\alpha}^{(n-1)}$  to control the type-I error.

We have  $T - \frac{\mu_1 - \mu_0}{S/\sqrt{n}} \stackrel{H_1}{\sim} \text{St}_{n-1}$ , so

$$\beta = \mathbb{P}_1(T \leq t_c) = \mathbb{P}_1\left(T - \frac{\mu_1 - \mu_0}{S/\sqrt{n}} \leq t_c - \frac{\mu_1 - \mu_0}{S/\sqrt{n}}\right) = F_{\text{St}_{n-1}}\left(-\sqrt{n}\left(\frac{\mu_1 - \mu_0}{S}\right) + t_c\right).$$

The p-value is  $p_{\text{obs}} = \mathbb{P}_0(T \geq t_{\text{obs}}) = (1 - F_{\text{St}_{n-1}}(t_{\text{obs}}))$ .



## Two-sided Student test

We assume that  $X_1, \dots, X_n \stackrel{\text{iid}}{\sim} \mathcal{N}(\mu, \sigma^2)$  where  $\sigma$  is **unknown**.

- We consider the composite alternative  $H_0 : \mu = \mu_0$  vs  $H_1 : \mu \neq \mu_0$ .
- We consider the *test statistic*

$$|T(X_1, \dots, X_n)| = |T| := \left| \frac{\bar{X} - \mu_0}{S/\sqrt{n}} \right|.$$

We have  $T \stackrel{H_0}{\sim} \text{St}_{n-2}$ , so  $\mathbb{P}_0(|T| > t_{1-\alpha/2}^{(n-1)}) = 1 - \mathbb{P}_0(t_{\alpha/2}^{(n-1)} \leq T \leq t_{1-\alpha/2}^{(n-1)}) = \alpha$  and we can choose  $t_c = t_{1-\alpha/2}^{(n-1)}$  to control the type-I error.

The p-value is  $p_{\text{obs}} = \mathbb{P}_0(|T| \geq |t_{\text{obs}}|) = 2(1 - F_{\text{St}_{n-1}}(|t_{\text{obs}}|))$

## One-sided asymptotic Gaussian test

We assume that  $X_1, \dots, X_n \stackrel{\text{iid}}{\sim} P$  where  $P$  is unknown, but we assume that  $\mathbb{E}[X_1^2] < \infty$ .

- We consider the simple alternative  $H_0 : \mu = \mu_0$  vs  $H_1 : \mu = \mu_1$  with  $\mu_1 > \mu_0$ .
- We consider the *test statistic*

$$T(X_1, \dots, X_n) = T := \frac{\bar{X} - \mu_0}{\hat{\sigma}/\sqrt{n}},$$

where  $\hat{\sigma}$  is a consistent estimator of  $\sigma$ , like  $S$  for example.

By the CLT, under  $H_0$ ,  $T \xrightarrow[n \rightarrow \infty]{(d)} \mathcal{N}(0, 1)$ , so  $\mathbb{P}_0(T > z_{1-\alpha}) \xrightarrow[n \rightarrow \infty]{} \alpha$  and we can choose  $t_c = z_{1-\alpha}$  to *asymptotically* control the type-I error.

Symmetrically, under  $H_1$ ,  $T - \frac{\mu_1 - \mu_0}{\hat{\sigma}/\sqrt{n}} \xrightarrow[n \rightarrow \infty]{(d)} \mathcal{N}(0, 1)$ , so

$$\beta = \mathbb{P}_1(T \leq t_c) = \mathbb{P}_1\left(T - \frac{\mu_1 - \mu_0}{\hat{\sigma}/\sqrt{n}} \leq t_c - \frac{\mu_1 - \mu_0}{\hat{\sigma}/\sqrt{n}}\right) \approx \Phi\left(-\sqrt{n}\left(\frac{\mu_1 - \mu_0}{\hat{\sigma}}\right) + t_c\right).$$

We can define similarly two-sided asymptotic Gaussian tests.

## One-sided $\chi^2$ test for the variance $\sigma^2$

We assume that  $X_1, \dots, X_n \stackrel{\text{iid}}{\sim} \mathcal{N}(\mu, \sigma^2)$  where  $\mu$  is **unknown**.

- We consider the simple alternative  $H_0 : \sigma = \sigma_0$  vs  $H_1 : \sigma = \sigma_1$  with  $\sigma_1 > \sigma_0$ .
- We consider the *test statistic*

$$T(X_1, \dots, X_n) = T := (n-1) \frac{S^2}{\sigma_0^2} = \frac{1}{\sigma_0^2} \sum_{i=1}^n (X_i - \bar{X})^2.$$

We have  $T \stackrel{H_0}{\sim} \chi_{n-1}^2$ , so if  $\chi_{n-1, 1-\alpha}^2$  is the quantile of level  $1 - \alpha$  of a  $\chi_{n-1}^2$  distribution,  $\mathbb{P}_0(T > \chi_{n-1, 1-\alpha}^2) = \alpha$  and we can choose  $t_c = \chi_{n-1, 1-\alpha}^2$  to control the type-I error.

We have  $\frac{\sigma_0^2}{\sigma_1^2} T \stackrel{H_1}{\sim} \chi_{n-1}^2$ , so  $\beta = \mathbb{P}_1(T \leq t_c) = \mathbb{P}_1\left(\frac{\sigma_0^2}{\sigma_1^2} T \leq \frac{\sigma_0^2}{\sigma_1^2} t_c\right) = F_{\chi_{n-1}^2}\left(\frac{\sigma_0^2}{\sigma_1^2} t_c\right)$ .

The p-value is  $p_{\text{obs}} = \mathbb{P}_0(T \geq t_{\text{obs}}) = (1 - F_{\chi_{n-1}^2}(t_{\text{obs}}))$ , with  $F_{\chi_{n-1}^2}$  the cdf of a  $\chi_{n-1}^2$  r.v.  
We could define similarly a two-sided  $\chi^2$  test.

## Two-sided Wald test

We assume that  $\hat{\theta}$  is the MLE for the parameter  $\theta$  based on an i.i.d. sample  $X_1, \dots, X_n \stackrel{\text{iid}}{\sim} p(\cdot; \eta)$  with  $\theta = \psi(\eta)$ . We consider the log-likelihood  $\ell(\theta)$ , the Fisher information matrix  $I(\theta)$ .

- We consider the composite alternative  $H_0 : \theta = \theta_0$  vs  $H_1 : \theta \neq \theta_0$ .
- We consider the *test statistic*  $|T|$  with

$$T(X_1, \dots, X_n) = T := \sqrt{I(\hat{\theta})}(\hat{\theta} - \theta_0).$$

By the CLT with Slutsky, under  $H_0$ ,  $T \xrightarrow[n \rightarrow \infty]{(d)} \mathcal{N}(0, 1)$ , so  $\mathbb{P}_0(|T| > z_{1-\alpha/2}) \xrightarrow[n \rightarrow \infty]{} 1 - \alpha$  and we can choose  $t_c = z_{1-\alpha/2}$  to *asymptotically* control the type-I error.

We can define an asymptotic p-value  $\mathbb{P}_0(|T| > |t_{\text{obs}}|) = 2(1 - \Phi(|t_{\text{obs}}|))$ .

## Summary

- In the Neyman-Pearson framework a null hypothesis  $H_0$  is the default hypothesis.
- We can *reject* the null hypothesis in favor of an alternative if the value of a *test statistics* is larger than a *critical value*.
- We focus on controlling the Type-I error level  $\alpha$ , aka the *significance level*.
- Instead of setting the *critical value* based on a *significance level*.
- The p-value  $p_{\text{obs}}$  is the probability  $\mathbb{P}_0(T \geq t_{\text{obs}})$ .
- It is possible to construct one and two-sided Gaussian and Student tests.
- It is possible to construct asymptotic Gaussian tests.
- One form of asymptotic test for  $\hat{\theta}_{\text{MLE}}$  is the Wald test.
- The null is rejected at the confidence level  $\alpha$  in a two-sided test iff the parameter  $\mu_0$  or  $\theta_0$  is not in the corresponding (symmetric) confidence interval.
- The same holds for one-sided test, but with one-sided confidence intervals.